

SEARCHED			
Class	Sub.	Date	Exmr.
250	306, 307, 310, 311, 492.3 492.2 492.22	8/27/02	BES
Updated		04/24	BES

34

INTERFERENCE SEARCHED			
Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	Date	Exmr.
Report EAST Silicon on insulator or SOI, inspection of electron or SEM ⊕ substrate near runs #3 ⊕ image ⊕ defect Obsolete near 4 date	08/22 <del>08</del>	BES
(Silicon on Insulator or SOI) ⊕ (Box or (broad eq oxide) ⊕ (semi- conductor die) near analysis	12/19/02	BES
Updated	04/24	BES